# MOSFET - Power, Dual, N-Channel, SOIC-8 30 V, 7.5 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual SOIC-8 Surface Mount Package Saves Board Space
- This is a Pb-Free Device

#### **Applications**

- Disk Drives
- DC-DC Converters
- Printers

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

| Ratir   | ng   |                       | Symbol                            | Value          | Unit |
|---|--|-----------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage   |  |                       | $V_{DSS}$                         | 30             | V    |
| Gate-to-Source Voltage  | ,  |                       | $V_{GS}$                          | ±20            | V    |
| Continuous Drain  |  | $T_A = 25^{\circ}C$   | I <sub>D</sub>                    | 5.5            | Α    |
| Current R <sub>θJA</sub> (Note 1)   |  | T <sub>A</sub> = 70°C |                                   | 4.4            |      |
| Power Dissipation R <sub>0</sub> JA (Note 1)  |  | T <sub>A</sub> = 25°C | P <sub>D</sub>                    | 1.14           | W    |
| Continuous Drain  |  | T <sub>A</sub> = 25°C | I <sub>D</sub>                    | 4.5            | Α    |
| Current R <sub>θJA</sub> (Note 2)   | Steady   | T <sub>A</sub> = 70°C |                                   | 3.5            |      |
| Power Dissipation $R_{\theta JA}$ (Note 2)  | State  | T <sub>A</sub> = 25°C | P <sub>D</sub>                    | 0.68           | W    |
| Continuous Drain  |  | T <sub>A</sub> = 25°C | I <sub>D</sub>                    | 7.5            | Α    |
| Current R <sub>θJA</sub> t < 10 s<br>(Note 1)   |  | T <sub>A</sub> = 70°C |                                   | 6.0            |      |
| Power Dissipation $R_{\theta JA} t < 10 s \text{ (Note 1)}$   |  | T <sub>A</sub> = 25°C | P <sub>D</sub>                    | 1.95           | W    |
| Pulsed Drain Current  | T <sub>A</sub> = 25°C,<br>t <sub>p</sub> = 10 μs |                       | I <sub>DM</sub>                   | 30             | Α    |
| Operating Junction and Storage Temperature  |  |                       | T <sub>J</sub> , T <sub>STG</sub> | -55 to<br>+150 | °C   |
| Source Current (Body Diode)   |  |                       | I <sub>S</sub>                    | 2.0            | Α    |
| Single Pulse Drain-to-Source Avalanche Energy $T_J = 25^{\circ}C$ , $V_{DD} = 30$ V, $V_{GS} = 10$ V, $I_L = 7.5$ A <sub>pk</sub> , $L = 1.0$ mH, $R_G = 25$ $\Omega$ |  |                       | EAS                               | 28             | mJ   |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s)   |  |                       | TL                                | 260            | °C   |

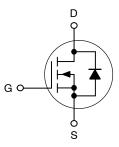


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| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> Max | I <sub>D</sub> Max |
|----------------------|-------------------------|--------------------|
| 30 V                 | 24 mΩ @ 10 V            | 7.5 A              |
|                      | 36 mΩ @ 4.5 V           | 7.671              |

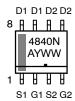
#### N-Channel



## MARKING DIAGRAM & PIN ASSIGNMENT



SOIC-8 CASE 751 STYLE 11



4840N = Device Code
A = Assembly Location
Y = Year
WW = Work Week
■ Pb-Free Package

#### **ORDERING INFORMATION**

| Device       | Package             | Shipping <sup>†</sup> |
|--------------|---------------------|-----------------------|
| NTMD4840NR2G | SOIC-8<br>(Pb-Free) | 2500/Tape & Reel      |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

| Rating                                      | Symbol          | Max   | Unit |
|---|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 1) | $R_{\theta JA}$ | 110   |      |
| Junction-to-Ambient – t≤10 s (Note 1)       | $R_{\theta JA}$ | 64    | °C/W |
| Junction-to-FOOT (Drain)                    | $R_{\theta JF}$ | 40    | C/VV |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 183.5 |      |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface—mounted on FR4 board using 1 inch sq pad size, 1 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)jk

| Characteristic   | Symbol                               | Test Con   | dition  | Min | Тур  | Max  | Unit  |
|--|--------------------------------------|--|---|-----|------|------|-------|
| OFF CHARACTERISTICS  | •                                    |  |   |     | -    |      | -     |
| Drain-to-Source Breakdown Voltage                              | V <sub>(BR)DSS</sub>                 | $V_{GS} = 0 \text{ V, } I_D$   | = 250 μA  | 30  |      |      | V     |
| Drain-to-Source Breakdown Voltage Tem-<br>perature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> |  |   |     | 18   |      | mV/°C |
| Zero Gate Voltage Drain Current                                | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 24 V                                       | T <sub>J</sub> = 25°C<br>T <sub>J</sub> = 100°C |     |      | 1.0  | μΑ    |
| Gate-to-Source Leakage Current                                 | I <sub>GSS</sub>                     | V <sub>DS</sub> = 0 V, V <sub>G</sub>  |   |     |      | ±100 | nA    |
| ON CHARACTERISTICS (Note 3)                                    | GSS                                  | VDS - 0 V, VG  | iS - ±20 V                                      |     |      | ±100 | ПА    |
| Gate Threshold Voltage   | V                                    | V V I-   | ΩEOΔ  | 1.5 |      | 3.0  | ΙV    |
| •  | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}, I_{DS}$  | ) = 250 μΑ                                      | 1.5 | 6.0  | 3.0  | - v   |
| Negative Threshold Temperature Coefficient                     | V <sub>GS(TH)</sub> /T <sub>J</sub>  |  |   |     | 6.0  |      | mV/°C |
| Drain-to-Source On Resistance                                  | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = 10 V   | I <sub>D</sub> = 6.9 A                          |     | 16   | 24   | mΩ    |
|  |                                      | V <sub>GS</sub> = 4.5 V  | I <sub>D</sub> = 5.0 A                          |     | 26   | 36   | 11152 |
| Forward Transconductance                                       | 9FS                                  | V <sub>DS</sub> = 1.5 V,   | I <sub>D</sub> = 6.9 A                          |     | 15   |      | S     |
| CHARGES, CAPACITANCES AND GATE F                               | RESISTANCE                           |  |   |     |      |      |       |
| Input Capacitance  | C <sub>ISS</sub>                     |  |   | 520 |      | pF   |       |
| Output Capacitance   | C <sub>OSS</sub>                     | V <sub>GS</sub> = 0 V, f = 1.0 M   |   | 140 |      |      |       |
| Reverse Transfer Capacitance                                   | C <sub>RSS</sub>                     |  |   | 70  |      |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  |  |   |     | 4.8  |      | 1     |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   | V 45VV   |   | 1.1 |      | nC   |       |
| Gate-to-Source Charge  | $Q_{GS}$                             | $V_{GS} = 4.5 \text{ V}, V_{DS} =$   |   | 2.1 |      |      |       |
| Gate-to-Drain Charge   | $Q_{GD}$                             |  |   |     | 1.9  |      | 1     |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 6.9 A                 |   |     | 9.5  |      | nC    |
| SWITCHING CHARACTERISTICS (Note 4)                             |                                      |  |   |     |      |      |       |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                   |  |   |     | 7.6  |      |       |
| Rise Time  | t <sub>r</sub>                       | V <sub>GS</sub> = 10 V, V  | nn = 15 V,                                      |     | 5.0  |      | 7     |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                  | $I_D = 1.0 \text{ A}, R_G = 3.0 \Omega$  |   |     | 17   |      | ns ns |
| Fall Time  | t <sub>f</sub>                       |  |   |     | 3.0  |      |       |
| DRAIN-TO-SOURCE CHARACTERISTICS                                | <u> </u>                             | •  | •   |     | •    |      | •     |
| Forward Diode Voltage  | $V_{SD}$                             | V <sub>GS</sub> = 0 V  | T <sub>J</sub> = 25°C                           |     | 0.76 | 1.0  | V     |
|  |                                      | I <sub>D</sub> = 2.0 A   | T <sub>J</sub> = 125°C                          |     | 0.58 |      |       |
| Reverse Recovery Time  | t <sub>RR</sub>                      |  | 1   |     | 12.5 |      | 1     |
| Charge Time  | Ta                                   | $V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A}/\mu\text{s,}$ $I_S = 2.0 \text{ A}$ |   |     | 7.3  |      | ns    |
| Discharge Time   | T <sub>b</sub>                       |  |   |     | 5.2  |      | 1     |
| Reverse Recovery Time  | Q <sub>RR</sub>                      |  |   |     | 6.0  |      | nC    |
| PACKAGE PARASITIC VALUES                                       | •                                    |  |   |     |      |      |       |
| Source Inductance  | L <sub>S</sub>                       |  |   |     | 0.66 |      | nH    |
| Drain Inductance   | L <sub>D</sub>                       |  | <b>500</b>                                      |     | 0.20 |      | nH    |
| Gate Inductance  | L <sub>G</sub>                       | T <sub>A</sub> = 25°C  |   |     | 1.50 |      | nH    |
| Gate Resistance  | $R_{G}$                              |  |   |     | 2.0  | 3.0  | Ω     |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL PERFORMANCE CURVES**

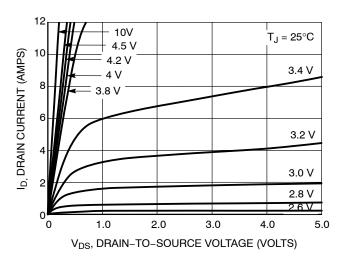
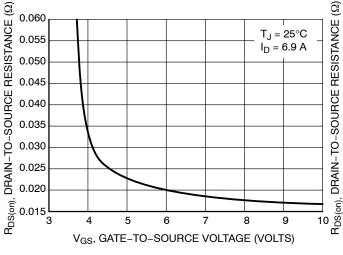


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



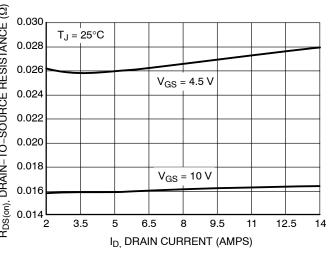
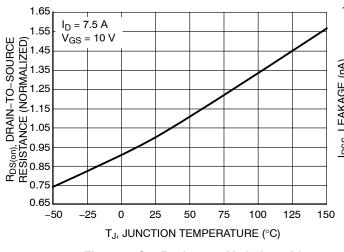


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



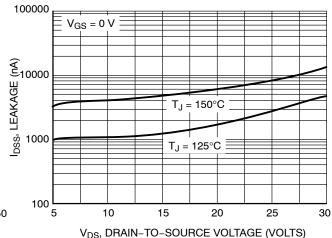


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**

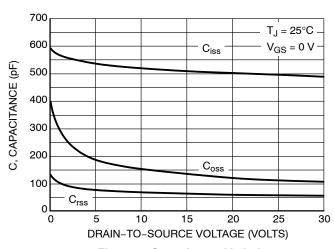


Figure 7. Capacitance Variation

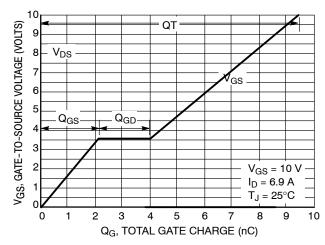


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

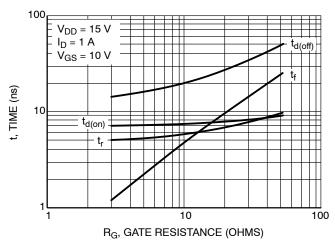


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

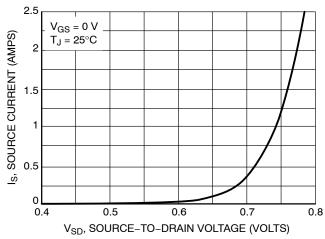


Figure 10. Diode Forward Voltage vs. Current

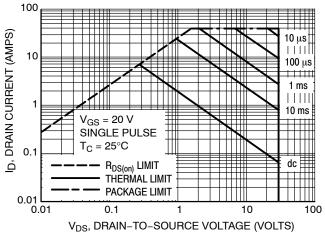


Figure 11. Maximum Rated Forward Biased Safe Operating Area

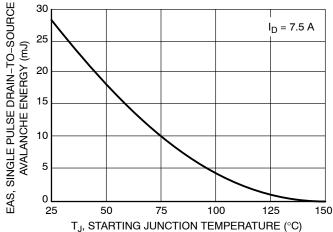


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature



SOIC-8 NB CASE 751-07 **ISSUE AK** 

**DATE 16 FEB 2011** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

|     | MILLIMETERS |      | INCHES    |       |  |
|-----|-------------|------|-----------|-------|--|
| DIM | MIN         | MAX  | MIN       | MAX   |  |
| Α   | 4.80        | 5.00 | 0.189     | 0.197 |  |
| В   | 3.80        | 4.00 | 0.150     | 0.157 |  |
| С   | 1.35        | 1.75 | 0.053     | 0.069 |  |
| D   | 0.33        | 0.51 | 0.013     | 0.020 |  |
| G   | 1.27 BSC    |      | 0.050 BSC |       |  |
| Н   | 0.10        | 0.25 | 0.004     | 0.010 |  |
| J   | 0.19        | 0.25 | 0.007     | 0.010 |  |
| K   | 0.40        | 1.27 | 0.016     | 0.050 |  |
| М   | 0 °         | 8 °  | 0 °       | 8 °   |  |
| N   | 0.25        | 0.50 | 0.010     | 0.020 |  |
| S   | 5.80        | 6.20 | 0.228     | 0.244 |  |

#### **SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location

= Wafer Lot = Year = Work Week

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

#### **STYLES ON PAGE 2**

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#### SOIC-8 NB CASE 751-07 ISSUE AK

### DATE 16 FEB 2011

| STYLE 3: PIN 1. DRAIN, PIE #1 CTOR, #1 CTOR, #2 CTOR, #1 CTOR, #2 CTOR, #2 CTOR, #2 CTOR, #2 CTOR, #1 | 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE  STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #1 Vd  STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN 8. TYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #1 |
|---|---|
| E PIN 1. INPUT 2. EXTERNAL BY 3. THIRD STAGE 4. GROUND E 5. DRAIN 6. GATE 3 7. SECOND STAGE 8. FIRST STAGE STYLE 11: ID PIN 1. SOURCE 1 2. GATE 1 T 3. SOURCE 2 ID 4. GATE 2 ID 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 ID 8. DRAIN 1 ID | PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 Vd 8. COLLECTOR, #1  STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN 8. TYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2   |
| ID PIN 1. SOURCE 1 2. GATE 1 T 3. SOURCE 2 ID 4. GATE 2 ID 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 ID 8. DRAIN 1 STYLE 15: RCE PIN 1. ANODE 1 E 2. ANODE 1 RCE 3. ANODE 1  | PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2   |
| STYLE 15:  RCE PIN 1. ANODE 1 E 2. ANODE 1 RCE 3. ANODE 1   | PIN 1. EMITTER, DIE #1<br>2. BASE, DIE #1<br>3. EMITTER, DIE #2   |
| N 7. CATHODE, CON<br>N 8. CATHODE, CON  | MMON         5. COLLECTOR, DIE #2           MMON         6. COLLECTOR, DIE #2           MMON         7. COLLECTOR, DIE #1           MMON         8. COLLECTOR, DIE #1   |
| STYLE 19: PIN 1. SOURCE 1 E 2. GATE 1 E 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 DE 7. DRAIN 1 DE 8. MIRROR 1   | STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN   |
| STYLE 23: E1 PIN 1. LINE 1 IN DN CATHODE/VCC 2. COMMON ANC DN CATHODE/VCC 3. COMMON ANC E3 4. LINE 2 IN DN ANODE/GND 5. LINE 2 OUT E4 6. COMMON ANC E5 7. COMMON ANC DN ANODE/GND 8. LINE 1 OUT   | ODE/GND 2. EMITTER ODE/GND 3. COLLECTOR/ANODE   |
| STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN  | STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V MON 6. VBULK 7. VBULK 8. VIN  |
| 1<br>1  |   |
| ;   | STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ E 5. SOURCE E 6. SOURCE E 7. SOURCE 8. DRAIN  |

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